

Notice of References Cited	Application/Control No. 10/763,164		Applicant(s)/Patent Under Reexamination LEE, CHAN-SUK	
	Examiner Alexander O. Williams		Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0155659 A1	08-2003	Verma et al.	257/777
*	B	US-2002/0140107 A1	10-2002	Kato et al.	257/777
*	C	US-2003/0011060 A1	01-2003	Le et al.	257/684
*	D	US-6,552,426 B2	04-2003	Ishio et al.	257/692
*	E	US-6,239,496 B1	05-2001	Asada, Junichi	257/777
*	F	US-6,476,506 B1	11-2002	O'Connor et al.	257/786
*	G	US-2003/0217858 A1	11-2003	Ho et al.	174/52.1
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.